

2SK1803

Silicon N-Channel Power F-MOS FET

■ Features

- Avalanche capacity guaranteed: $EAS > 60\text{mJ}$
- $V_{GSS} = \pm 30\text{V}$ guaranteed
- High-speed switching: $t_f = 80\text{ns}$
- No secondary breakdown

■ Applications

- Contactless relay
- Diving circuit for a solenoid
- Driving circuit for a motor
- Control equipment
- Switching power supply

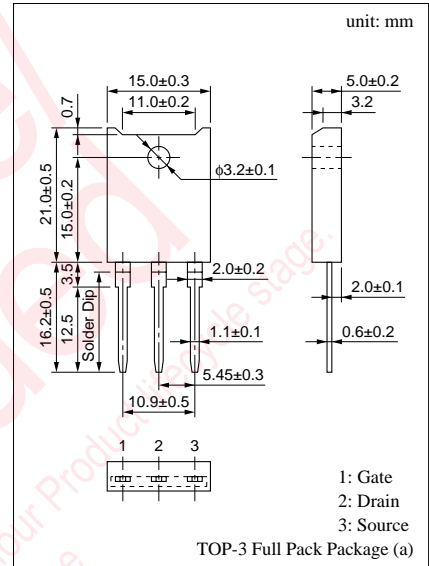
■ Absolute Maximum Ratings ($T_C = 25^\circ\text{C}$)

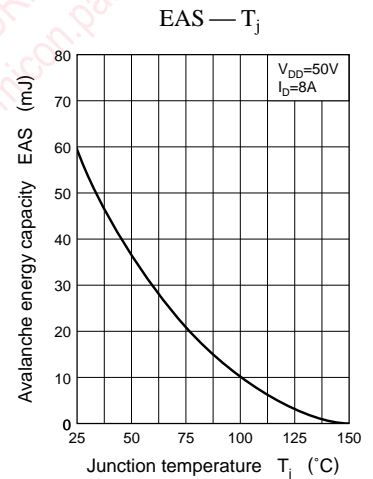
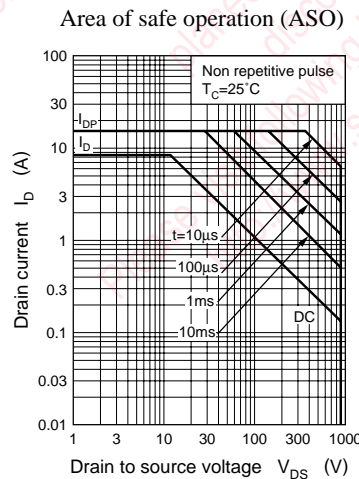
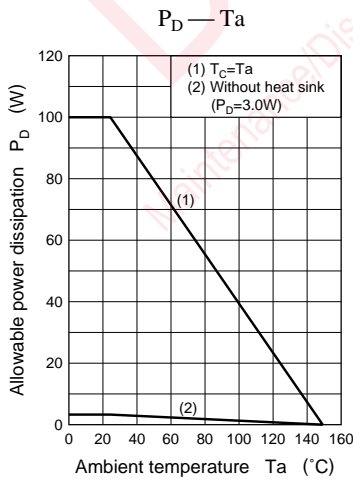
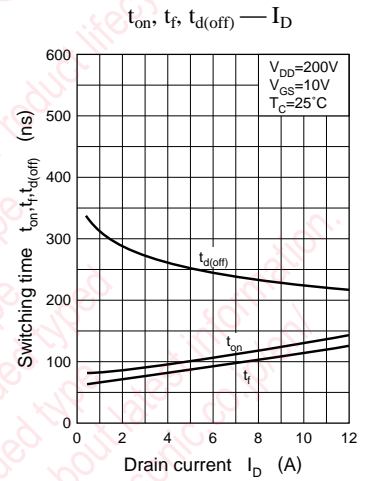
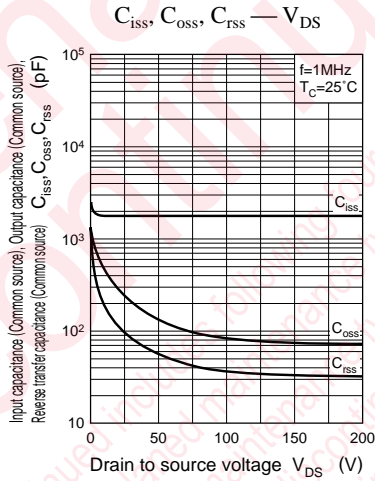
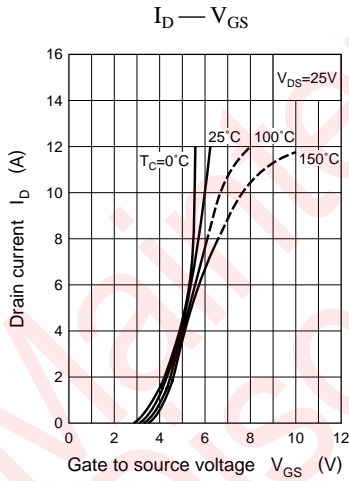
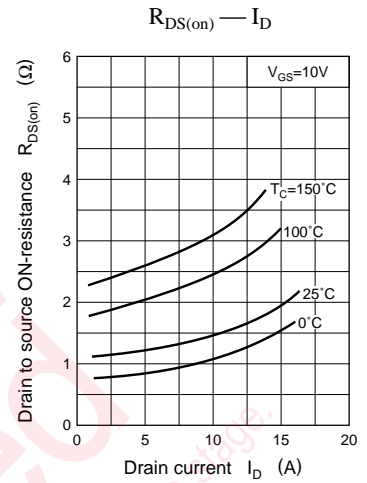
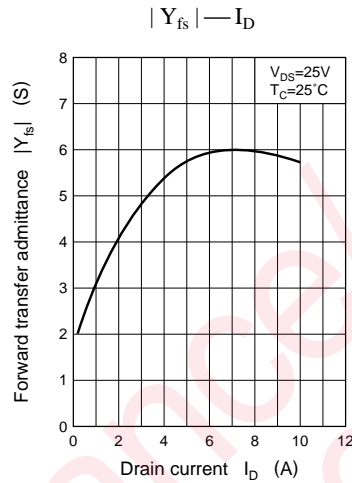
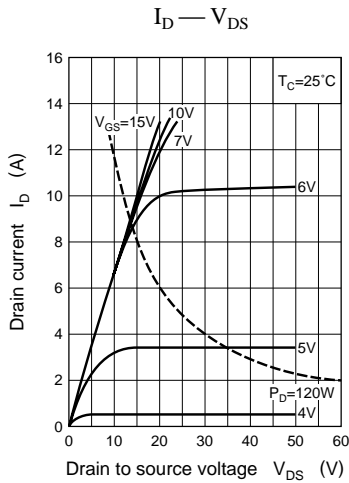
Parameter	Symbol	Rated	Unit
Drain to Source breakdown voltage	V_{DSS}	900	V
Gate to Source voltage	V_{GSS}	± 30	V
Drain current	DC	I_D	± 8 A
	Pulse	I_{DP}	± 16 A
Avalanche energy capacity	EAS^*	60	mJ
Allowable power dissipation	$T_C = 25^\circ\text{C}$	P_D	100 W
	$T_a = 25^\circ\text{C}$		3 W
Channel temperature	T_{ch}	150	$^\circ\text{C}$
Storage temperature	T_{stg}	-55 to +150	$^\circ\text{C}$

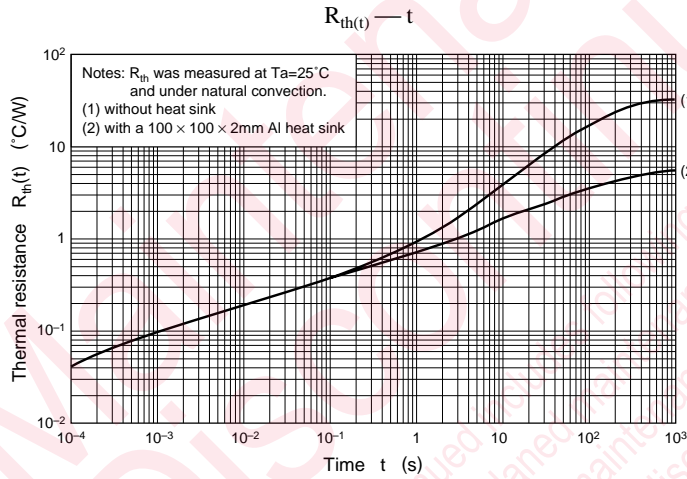
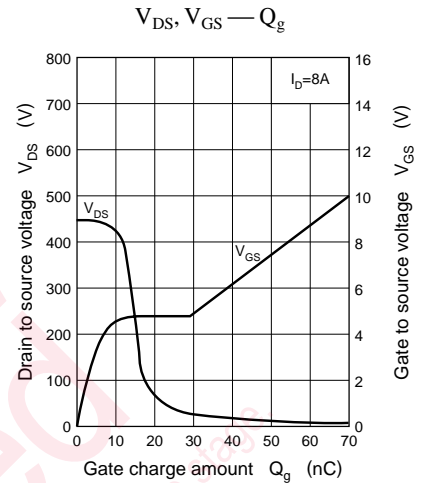
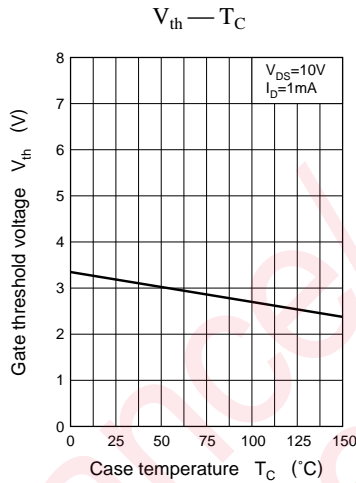
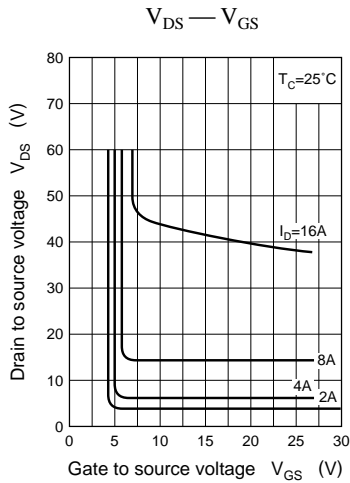
* $L = 1.9\text{mH}$, $I_L = 8\text{A}$, $V_{DD} = 50\text{V}$, 1 pulse

■ Electrical Characteristics ($T_C = 25^\circ\text{C}$)

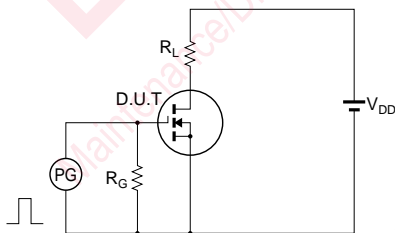
Parameter	Symbol	Conditions	min	typ	max	Unit	
Drain to Source cut-off current	I_{DSS}	$V_{DS} = 720\text{V}$, $V_{GS} = 0$			0.1	mA	
Gate to Source leakage current	I_{GSS}	$V_{GS} = \pm 30\text{V}$, $V_{DS} = 0$			± 1	μA	
Drain to Source breakdown voltage	V_{DSS}	$I_D = 1\text{mA}$, $V_{GS} = 0$	900			V	
Gate threshold voltage	V_{th}	$V_{DS} = 25\text{V}$, $I_D = 1\text{mA}$	1		5	V	
Drain to Source ON-resistance	$R_{DS(on)}$	$V_{GS} = 10\text{V}$, $I_D = 4\text{A}$		1.3	1.7	Ω	
Forward transfer admittance	$ Y_{fs} $	$V_{DS} = 25\text{V}$, $I_D = 4\text{A}$	3	5.5		S	
Diode forward voltage	V_{DSF}	$I_{DR} = 8\text{A}$, $V_{GS} = 0$			-1.6	V	
Input capacitance (Common Source)	C_{iss}	$V_{DS} = 20\text{V}$, $V_{GS} = 0$, $f = 1\text{MHz}$		1800		pF	
Output capacitance (Common Source)	C_{oss}				200		pF
Reverse transfer capacitance (Common Source)	C_{rss}				90		pF
Turn-on time	t_{on}	$V_{GS} = 10\text{V}$, $I_D = 4\text{A}$		100		ns	
Fall time	t_f		$V_{DD} = 200\text{V}$, $R_L = 50\Omega$		80		ns
Turn-off time (delay time)	$t_{d(off)}$			250		ns	
Thermal resistance between channel and case	$R_{th(ch-c)}$				1.25	$^\circ\text{C/W}$	



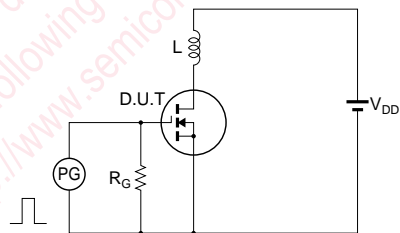




Switching measurement circuit



Avalanche energy capacity test circuit



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